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EMI Tests in MTCA.4

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EMI problems in MTCA.4 system can degrade the whole system accuracy. An AMC board called DAMC-EMI board was developed at DESY to easily identify the conductive mode EMI problems in MTCA.4 system. Now a new revision (R1.1) of the board has been developed. A selected measurement results which show some of the EMI problems in MTCA.4 systems are presented.

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